Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/777,125	KOBAYASHI ET AL.	
Examiner	Art Unit	
Biju Chandran	2835	

SEARCHED					
Class	Subclass	Date	Examiner		
361	715	1/27/2006	BIC		
439	76.2	1/27/2006	BIC		
361	704	1/27/2006	bic		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see search history				